<u> </u>	Application No.	Applicant(s)
Notice of Allowability	10/718,674	CHANG, MING-HSUAN
	Examiner	Art Unit
	Thomas L. Dickey	2826
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS (herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIG	(OR REMAINS) CLOSED in to other appropriate commun GHTS. This application is suluded MPEP 1308.	his application. If not included ication will be mailed in due course. THIS
1. This communication is responsive to <u>amendment filed 06/1</u>	<u>4/2005</u> .	
2. ☑ The allowed claim(s) is/are <u>10,11 and 13-15</u> .		
3. $\boxtimes$ The drawings filed on <u>24 November 2003</u> are accepted by	the Examiner.	
<ul> <li>4. Acknowledgment is made of a claim for foreign priority un</li> <li>a) All b) Some* c) None of the:</li> <li>1. Certified copies of the priority documents have</li> <li>2. Certified copies of the priority documents have</li> <li>3. Copies of the certified copies of the priority documents have</li> <li>International Bureau (PCT Rule 17.2(a)).</li> <li>* Certified copies not received:</li> </ul>	been received. been received in Application	No
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONMI THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a ENT of this application.	reply complying with the requirements
<ol> <li>A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give</li> </ol>	tted. Note the attached EXAM s reason(s) why the oath or d	INER'S AMENDMENT or NOTICE OF leclaration is deficient.
6. $\square$ CORRECTED DRAWINGS ( as "replacement sheets") must	t be submitted.	
(a) Including changes required by the Notice of Draftsperson	on's Patent Drawing Review (	PTO-948) attached
1)  hereto or 2) to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	Amendment / Comment or in	the Office action of
Identifying indicia such as the application number (see 37 CFR 1.	84(c)) should be written on the	drawings in the front (not the back) of
<ol> <li>DEPOSIT OF and/or INFORMATION about the depose attached Examiner's comment regarding REQUIREMENT F</li> </ol>	sit of BIOLOGICAL MATER	RIAL must be submitted. Note the
Attachment(s)  1. ☐ Notice of References Cited (PTO-892)	<u></u>	rmal Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6.  ☐ Interview Sum Paper No./M	
<ol> <li>Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date</li> </ol>		mendment/Comment
4. Examiner's Comment Regarding Requirement for Deposit	8. 🛛 Examiner's St	atement of Reasons for Allowance
of Biological Material	9.  Other	ckullen Ton
		Minhloan Tran
		Primary Examiner Art Unit 2826

U.S. Patent and Trademark Office PTOL-37 (Rev. 1-04) Art Unit: 2826

## **REASONS FOR ALLOWANCE**

1. The following is an examiner's statement of reasons for allowance:

Claims 10,11 and 13-15 are allowed over the references of record because none of these references disclosed or can be combined to yield the claimed invention such as a transistor having all the limitations of claim 10 as previously rejected, and in addition, the limitation that said projection of said fourth conducting structure onto said substrate approximately parallel to said projection of said third conducting structure onto said substrate at least seven times longer than said side of said projection of said fourth conducting structure onto said substrate approximately parallel to said projection of said first conducting structure onto said substrate.

Morozumi 4,600,274 discloses a transistor with a first conducting structure 43, for example, a signal/data line, upon a substrate 40; a second conducting structure 44, for example a scanning/gate line, upon said substrate 40, with the projection of said second conducting structure (scanning/gate line 44) onto said substrate 40 intersecting the projection of said first conducting structure (signal/data line 43) onto said substrate 40; a third conducting structure 53, for example a source, upon said substrate 40 contacting with said first conducting structure (signal/data line 43), with the projection of said third conducting structure (source 53) onto said substrate 40 completely inside said projection of said second conducting structure (scanning/gate line 44) onto said substrate 40; and a fourth conducting structure 50, for example a gate, upon said

Art Unit: 2826

substrate 40, with the projection of said fourth conducting structure (gate 50) onto said substrate 40 separated from said projection of said first (signal/data line 43) and said third conducting structure (source 53) onto said substrate 40, said projection of said fourth conducting structure (gate 50) onto said substrate 40 completely inside said projection of said second conducting structure (scanning/gate line 44) onto said substrate 40; and said projection of said fourth conducting structure (gate 50) onto said substrate 40 approximately parallel to said projection of said third conducting structure (source 53) onto said substrate 40. Note figures 4a, 4c, and column 4 lines 15-36 and 54-68 of Morozumi. Morozumi does not disclose that said side (hereinafter "first side") of said projection of said fourth conducting structure (gate 50) onto said substrate 40 approximately parallel to said projection of said third conducting structure (source 53) onto said substrate 40 is at least seven times longer than said side (hereinafter "second side") of said projection of said fourth conducting structure (gate 50) onto said substrate 40 approximately parallel to said projection of said first conducting structure (signal/data line 43) onto said substrate 40. In his text, Morozumi neglects to compare said first side to said second side. In Morozumi's drawings (which are not to scale) the first side overlaps the second side and for this reason is clearly a little longer. However, given that the drawings are not to scale, there is no guarantee that the first side is disclosed as being seven times longer than the second side, as is required by claim 10.

2. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably

Application/Control Number: 10/718,674

Page 4

Art Unit: 2826

accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Conclusion

3. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thomas L Dickey whose telephone number is 571-272-1913. The examiner can normally be reached on Monday-Thursday 8-6.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J Flynn can be reached on 703-308-6601. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

TLD 06/05